



Welcome to [E-XFL.COM](#)

What is "[Embedded - Microcontrollers](#)"?

"[Embedded - Microcontrollers](#)" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "[Embedded - Microcontrollers](#)"

Details

Product Status	Obsolete
Core Processor	F ² MC-16FX
Core Size	16-Bit
Speed	32MHz
Connectivity	CANbus, I ² C, LINbus, SCI, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	101
Program Memory Size	96KB (96K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	10K x 8
Voltage - Supply (Vcc/Vdd)	2.7V ~ 5.5V
Data Converters	A/D 29x8/10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 125°C (TA)
Mounting Type	Surface Mount
Package / Case	120-LQFP
Supplier Device Package	120-LQFP (16x16)
Purchase URL	https://www.e-xfl.com/product-detail/infineon-technologies/mb96f653rbpmc-gse2

MB96650 series is based on Cypress's advanced F²MC-16FX architecture (16-bit with instruction pipeline for RISC-like performance). The CPU uses the same instruction set as the established F²MC-16LX family thus allowing for easy migration of F²MC-16LX Software to the new F²MC-16FX products. F²MC-16FX product improvements compared to the previous generation include significantly improved performance - even at the same operation frequency, reduced power consumption and faster start-up time. For high processing speed at optimized power consumption an internal PLL can be selected to supply the CPU with up to 32MHz operation frequency from an external 4MHz to 8MHz resonator. The result is a minimum instruction cycle time of 31.2ns going together with excellent EMI behavior. The emitted power is minimized by the on-chip voltage regulator that reduces the internal CPU voltage. A flexible clock tree allows selecting suitable operation frequencies for peripheral resources independent of the CPU speed.

Features

Technology

0.18μm CMOS

CPU

- F²MC-16FX CPU
- Optimized instruction set for controller applications (bit, byte, word and long-word data types, 23 different addressing modes, barrel shift, variety of pointers)
- 8-byte instruction queue
- Signed multiply (16-bit × 16-bit) and divide (32-bit/16-bit) instructions available

System clock

- On-chip PLL clock multiplier (×1 to ×8, ×1 when PLL stop)
- 4MHz to 8MHz crystal oscillator (maximum frequency when using ceramic resonator depends on Q-factor)
- Up to 8MHz external clock for devices with fast clock input feature
- 32.768kHz subsystem quartz clock
- 100kHz/2MHz internal RC clock for quick and safe startup, clock stop detection function, watchdog
- Clock source selectable from mainclock oscillator, subclock oscillator and on-chip RC oscillator, independently for CPU and 2 clock domains of peripherals
- The subclock oscillator is enabled by the Boot ROM program controlled by a configuration marker after a Power or External reset
- Low Power Consumption - 13 operating modes (different Run, Sleep, Timer, Stop modes)

On-chip voltage regulator

Internal voltage regulator supports a wide MCU supply voltage range (Min=2.7V), offering low power consumption

Low voltage detection function

Reset is generated when supply voltage falls below programmable reference voltage

Code Security

Protects Flash Memory content from unintended read-out

DMA

Automatic transfer function independent of CPU, can be assigned freely to resources

Interrupts

- Fast Interrupt processing
- 8 programmable priority levels
- Non-Maskable Interrupt (NMI)

CAN

- Supports CAN protocol version 2.0 part A and B
- ISO16845 certified
- Bit rates up to 1Mbps
- 32 message objects
- Each message object has its own identifier mask
- Programmable FIFO mode (concatenation of message objects)
- Maskable interrupt
- Disabled Automatic Retransmission mode for Time Triggered CAN applications
- Programmable loop-back mode for self-test operation

USART

- Full duplex USARTs (SCI/LIN)

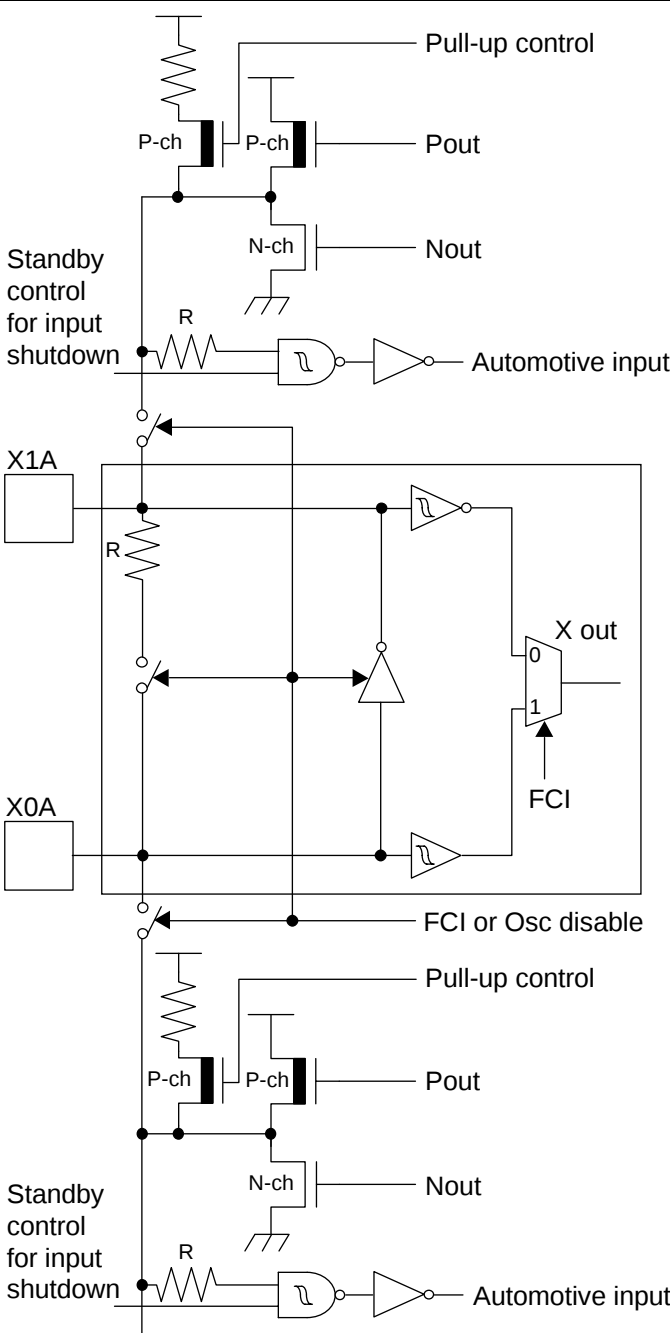
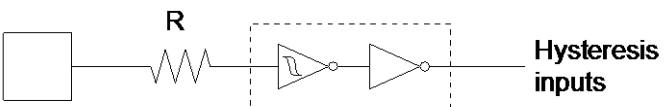
Contents

1. Product Lineup	5
2. Block Diagram	6
3. Pin Assignment	7
4. Pin Description	8
5. Pin Circuit Type	10
6. I/O Circuit Type	14
7. Memory Map	19
8. Ramstart Addresses	20
9. User ROM Memory Map for Flash Devices	21
10. Serial Programming Communication Interface	22
11. Interrupt Vector Table	23
12. Handling Precautions	27
12.1 Precautions for Product Design	27
12.2 Precautions for Package Mounting	28
12.3 Precautions for Use Environment	29
13. Handling Devices	30
14. Electrical Characteristics	33
14.1 Absolute Maximum Ratings	33
14.2 Recommended Operating Conditions	35
14.3 DC Characteristics	36
14.3.1 Current Rating	36
14.3.2 Pin Characteristics	40
14.4 AC Characteristics	42
14.4.1 Main Clock Input Characteristics	42
14.4.2 Sub Clock Input Characteristics	44
14.4.3 Built-in RC Oscillation Characteristics	45
14.4.4 Internal Clock Timing	45
14.4.5 Operating Conditions of PLL	46
14.4.6 Reset Input	46
14.4.7 Power-on Reset Timing	47
14.4.8 USART Timing	48
14.4.9 External Input Timing	50
14.4.10 I ² C Timing	51
14.5 A/D Converter	52
14.5.1 Electrical Characteristics for the A/D Converter	52
14.5.2 Accuracy and Setting of the A/D Converter Sampling Time	53
14.5.3 Definition of A/D Converter Terms	54
14.6 Low Voltage Detection Function Characteristics	56
14.7 Flash Memory Write/Erase Characteristics	58
15. Example Characteristics	59
16. Ordering Information	62
17. Package Dimension	63
18. Major Changes	64
Document History	65

1. Product Lineup

Features		MB96650	Remark
Product Type		Flash Memory Product	
Subclock		Subclock can be set by software	
Dual Operation Flash Memory	RAM	-	
64.5KB + 32KB	10KB	MB96F653R, MB96F653A	Product Options R: MCU with CAN A: MCU without CAN
128.5KB + 32KB	16KB	MB96F655R, MB96F655A	
256.5KB + 32KB	24KB	MB96F656R	
384.5KB + 32KB	28KB	MB96F657R	
Package		LQFP-120: LQM120	
DMA		4ch	
USART		6ch	LIN-USART 0 to 2/4/5/7
	with automatic LIN-Header transmission/reception	Yes (only 1ch)	LIN-USART 0
	with 16 byte RX- and TX-FIFO	No	
I ² C		2ch	I ² C 0/1
8/10-bit A/D Converter		29ch	AN 0 to 28
	with Data Buffer	No	
	with Range Comparator	Yes	
	with Scan Disable	Yes	
	with ADC Pulse Detection	No	
16-bit Reload Timer (RLT)		5ch	RLT 0 to 3/6
16-bit Free-Running Timer (FRT)		3ch	FRT 0 to 2
16-bit Input Capture Unit (ICU)		7ch (1 channel for LIN-USART)	ICU 0/1/4 to 7/9 ICU 9 for LIN-USART
16-bit Output Compare Unit (OCU)		7ch	OCU 0 to 4/6/7 (OCU 4 for FRT clear)
8/16-bit Programmable Pulse Generator (PPG)		16ch (16-bit) / 32ch (8-bit)	PPG 0 to 15
	with Timing point capture	Yes	
	with Start delay	Yes	
	with Ramp	No	
Quadrature Position/Revolution Counter (QPRC)		2ch	QPRC 0/1
CAN Interface		1ch	CAN 0 32 Message Buffers
External Interrupts (INT)		16ch	INT 0 to 15
Non-Maskable Interrupt (NMI)		1ch	
Real Time Clock (RTC)		1ch	
I/O Ports		99 (Dual clock mode) 101 (Single clock mode)	
Clock Calibration Unit (CAL)		1ch	
Clock Output Function		2ch	
Low Voltage Detection Function		Yes	Low voltage detection function can be disabled by software
Hardware Watchdog Timer		Yes	
On-chip RC-oscillator		Yes	
On-chip Debugger		Yes	

Note: All signals of the peripheral function in each product cannot be allocated by limiting the pins of package. It is necessary to use the port relocate function of the general I/O port according to your function use.

Type	Circuit	Remarks
B	 The diagram illustrates a low-speed oscillation circuit shared with GPIO functionality. It features a pull-up control circuit with P-ch and N-ch transistors, labeled Pout and Nout. A standby control for input shutdown is shown, along with an automotive input circuit. The circuit includes two input blocks, X1A and X0A, which are connected to a feedback resistor R. The output of the circuit is X out, which is controlled by FCI (Fast Charge Injection) or Osc disable. The circuit also includes a pull-up control circuit with P-ch and N-ch transistors, labeled Pout and Nout, and a standby control for input shutdown.	Low-speed oscillation circuit shared with GPIO functionality: ■ Feedback resistor = approx. 5.0MΩ ■ GPIO functionality selectable (CMOS level output ($I_{OL} = 4\text{mA}$, $I_{OH} = -4\text{mA}$), Automotive input with input shutdown function and programmable pull-up resistor)
C	 The diagram shows a CMOS hysteresis input pin circuit. It consists of a resistor R connected to a hysteresis input circuit, which is represented by a dashed box containing two inverters. The output of the hysteresis input circuit is labeled Hysteresis inputs.	CMOS hysteresis input pin

7. Memory Map

FF:FFF _H	USER ROM*1
DE:000 _H	
DD:FFF _H	Reserved
10:000 _H	
0F:C00 _H	Boot-ROM
	Peripheral
0E:900 _H	
	Reserved
01:000 _H	
00:800 _H	ROM/RAM MIRROR
	Internal RAM bank0
RAMSTART0*2	
	Reserved
00:0C0 _H	
00:038 _H	Peripheral
00:018 _H	GPR*3
00:010 _H	DMA
00:00F _H	Reserved
00:000 _H	Peripheral

*1: For details about USER ROM area, see “□USER ROM MEMORY MAP FOR FLASH DEVICES” on the following pages.

*2: For RAMSTART addresses, see the table on the next page.

*3: Unused GPR banks can be used as RAM area.

GPR: General-Purpose Register

The DMA area is only available if the device contains the corresponding resource.

The available RAM and ROM area depends on the device.

Vector number	Offset in vector table	Vector name	Cleared by DMA	Index in ICR to program	Description
121	218 _H	-	-	121	Reserved
122	214 _H	-	-	122	Reserved
123	210 _H	-	-	123	Reserved
124	20C _H	-	-	124	Reserved
125	208 _H	-	-	125	Reserved
126	204 _H	-	-	126	Reserved
127	200 _H	-	-	127	Reserved
128	1FC _H	-	-	128	Reserved
129	1F8 _H	-	-	129	Reserved
130	1F4 _H	-	-	130	Reserved
131	1F0 _H	-	-	131	Reserved
132	1EC _H	-	-	132	Reserved
133	1E8 _H	FLASHA	Yes	133	Flash memory A interrupt
134	1E4 _H	-	-	134	Reserved
135	1E0 _H	-	-	135	Reserved
136	1DC _H	-	-	136	Reserved
137	1D8 _H	QPRC0	Yes	137	Quad Position/Revolution counter 0
138	1D4 _H	QPRC1	Yes	138	Quad Position/Revolution counter 1
139	1D0 _H	ADCRC0	No	139	A/D Converter 0 - Range Comparator
140	1CC _H	-	-	140	Reserved
141	1C8 _H	-	-	141	Reserved
142	1C4 _H	-	-	142	Reserved
143	1C0 _H	-	-	143	Reserved

14.2 Recommended Operating Conditions

($V_{SS} = AV_{SS} = 0V$)

Parameter	Symbol	Value			Unit	Remarks
		Min	Typ	Max		
Power supply voltage	V_{CC}, AV_{CC}	2.7	-	5.5	V	
		2.0	-	5.5	V	Maintains RAM data in stop mode
Smoothing capacitor at C pin	C_S	0.5	1.0 to 3.9	4.7	μF	1.0 μF (Allowance within $\pm 50\%$) 3.9 μF (Allowance within $\pm 20\%$) Please use the ceramic capacitor or the capacitor of the frequency response of this level. The smoothing capacitor at V_{CC} must use the one of a capacity value that is larger than C_S .

WARNING

The recommended operating conditions are required in order to ensure the normal operation of the semiconductor device. All of the device's electrical characteristics are warranted when the device is operated within these ranges.

Always use semiconductor devices within their recommended operating condition ranges. Operation outside these ranges may adversely affect reliability and could result in device failure. No warranty is made with respect to uses, operating conditions, or combinations not represented on the data sheet. Users considering application outside the listed conditions are advised to contact their representatives beforehand.

Parameter	Symbol	Pin name	Conditions	Value			Unit	Remarks
				Min	Typ	Max		
Power supply current in Stop mode*3	I _{CCH}	VCC	-	-	20	60	μA	T _A = +25°C
				-	-	880	μA	T _A = +105°C
				-	-	1845	μA	T _A = +125°C
Flash Power Down current	I _{CCFLASHPD}		-	-	36	70	μA	
Power supply current for active Low Voltage detector*4	I _{CCLVD}		Low voltage detector enabled	-	5	-	μA	T _A = +25°C
				-	-	12.5	μA	T _A = +125°C
Flash Write/ Erase current*5	I _{CCFLASH}		-	-	12.5	-	mA	T _A = +25°C
				-	-	20	mA	T _A = +125°C

*1: The power supply current is measured with a 4MHz external clock connected to the Main oscillator and a 32kHz external clock connected to the Sub oscillator. See chapter "Standby mode and voltage regulator control circuit" of the Hardware Manual for further details about voltage regulator control. Current for "On Chip Debugger" part is not included. Power supply current in Run mode does not include Flash Write / Erase current.

*2: The power supply current in Timer mode is the value when Flash is in Power-down / reset mode.

When Flash is not in Power-down / reset mode, $I_{CCFLASHPD}$ must be added to the Power supply current.

The power supply current is measured with a 4MHz external clock connected to the Main oscillator and a 32kHz external clock connected to the Sub oscillator. The current for "On Chip Debugger" part is not included.

*3: The power supply current in Stop mode is the value when Flash is in Power-down / reset mode.

When Flash is not in Power-down / reset mode, $I_{CCFLASHPD}$ must be added to the Power supply current.

*4: When low voltage detector is enabled, I_{CCLVD} must be added to Power supply current.

*5: When Flash Write / Erase program is executed, $I_{CCFLASH}$ must be added to Power supply current.

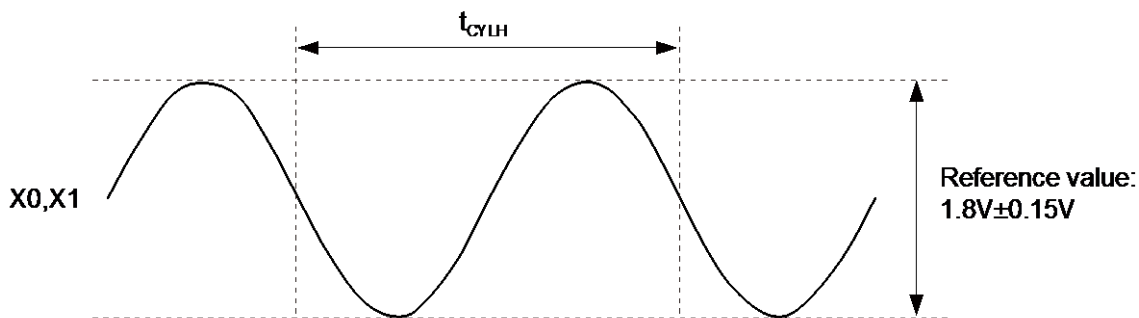
14.4 AC Characteristics

14.4.1 Main Clock Input Characteristics

($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_D = 1.8V \pm 0.15V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^\circ C$ to $+125^\circ C$)

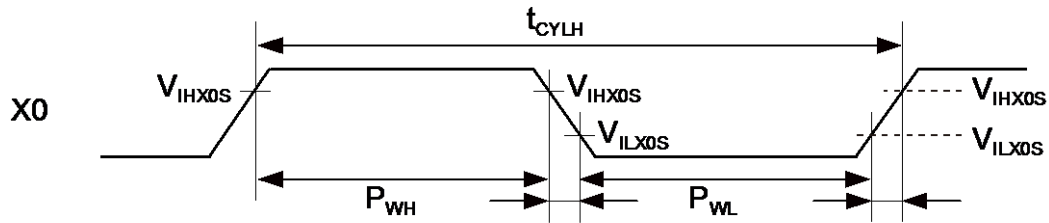
Parameter	Symbol	Pin name	Value			Unit	Remarks
			Min	Typ	Max		
Input frequency	f_c	X0, X1	4	-	8	MHz	When using a crystal oscillator, PLL off
			-	-	8	MHz	When using an opposite phase external clock, PLL off
			4	-	8	MHz	When using a crystal oscillator or opposite phase external clock, PLL on
Input frequency	f_{FCI}	X0	-	-	8	MHz	When using a single phase external clock in "Fast Clock Input mode", PLL off
			4	-	8	MHz	When using a single phase external clock in "Fast Clock Input mode", PLL on
Input clock cycle	t_{CYLH}	-	125	-	-	ns	
Input clock pulse width	P_{WH}, P_{WL}	-	55	-	-	ns	

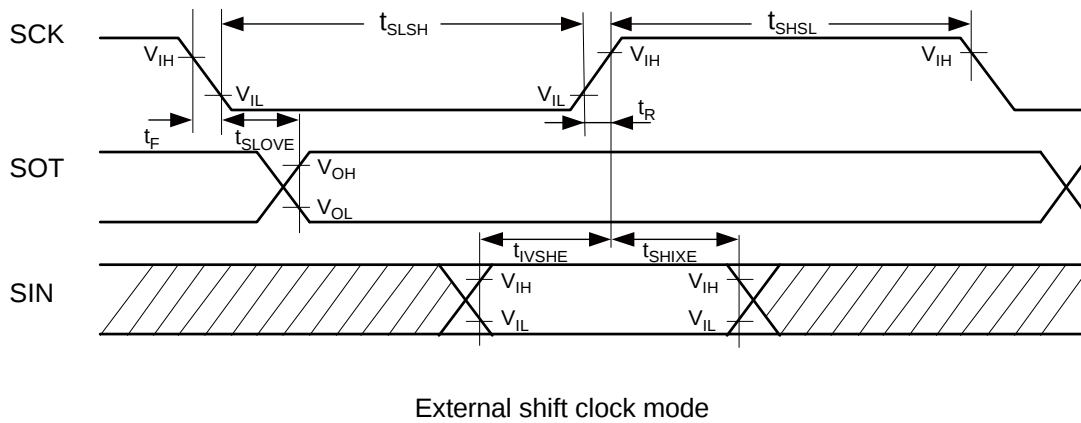
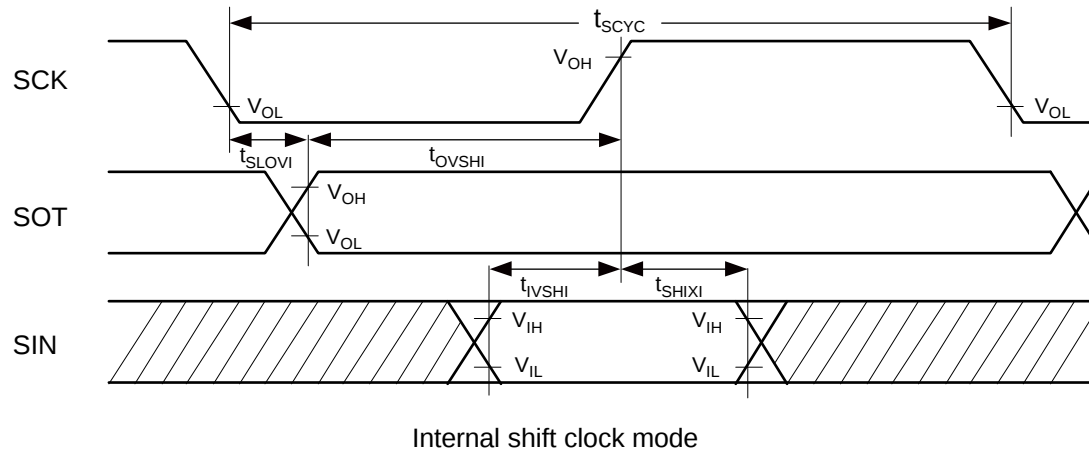
When using the crystal oscillator



The amplitude changes by resistance, capacity which added outside or the difference of the device.

When using the external clock





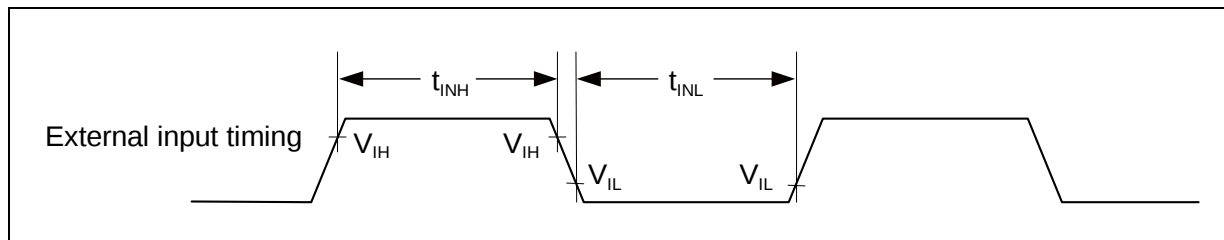
•

14.4.9 External Input Timing

($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$)

Parameter	Symbol	Pin name	Value		Unit	Remarks
			Min	Max		
Input pulse width	t_{INH} , t_{INL}	Pnn_m	$2t_{CLKP1} + 200$ ($t_{CLKP1} = 1/f_{CLKP1}$)*	-	ns	General Purpose I/O
		ADTG				A/D Converter trigger input
		TINn, TINn_R				Reload Timer
		TTGn				PPG trigger input
		FRCKn, FRCKn_R				Free-Running Timer input clock
		INn, INn_R				Input Capture
		AINn, BINn, ZINn				Quadrature Position/Revolution Counter
		INTn, INTn_R	200	-	ns	External Interrupt
		NMI				Non-Maskable Interrupt

*: t_{CLKP1} indicates the peripheral clock1 (CLKP1) cycle time except stop when in stop mode.



14.4.10 I²C Timing

($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$)

Parameter	Symbol	Conditions	Typical mode		High-speed mode*4		Unit
			Min	Max	Min	Max	
SCL clock frequency	f_{SCL}	$C_L = 50pF$, $R = (V_P/I_{OL})^{*1}$	0	100	0	400	kHz
(Repeated) START condition hold time SDA ↓ → SCL ↓	t_{HDSTA}		4.0	-	0.6	-	μs
SCL clock "L" width	t_{LOW}		4.7	-	1.3	-	μs
SCL clock "H" width	t_{HIGH}		4.0	-	0.6	-	μs
(Repeated) START condition setup time SCL ↑ → SDA ↓	t_{SUSTA}		4.7	-	0.6	-	μs
Data hold time SCL ↓ → SDA ↓ ↑	t_{HDDAT}		0	3.45^{*2}	0	0.9^{*3}	μs
Data setup time SDA ↓ ↑ → SCL ↑	t_{SUDAT}		250	-	100	-	ns
STOP condition setup time SCL ↑ → SDA ↑	t_{SUSTO}		4.0	-	0.6	-	μs
Bus free time between "STOP condition" and "START condition"	t_{BUS}		4.7	-	1.3	-	μs
Pulse width of spikes which will be suppressed by input noise filter	t_{SP}	-	0	$(1-1.5) \times t_{CLKP1}^{*5}$	0	$(1-1.5) \times t_{CLKP1}^{*5}$	ns

*1: R and C_L represent the pull-up resistance and load capacitance of the SCL and SDA lines, respectively.

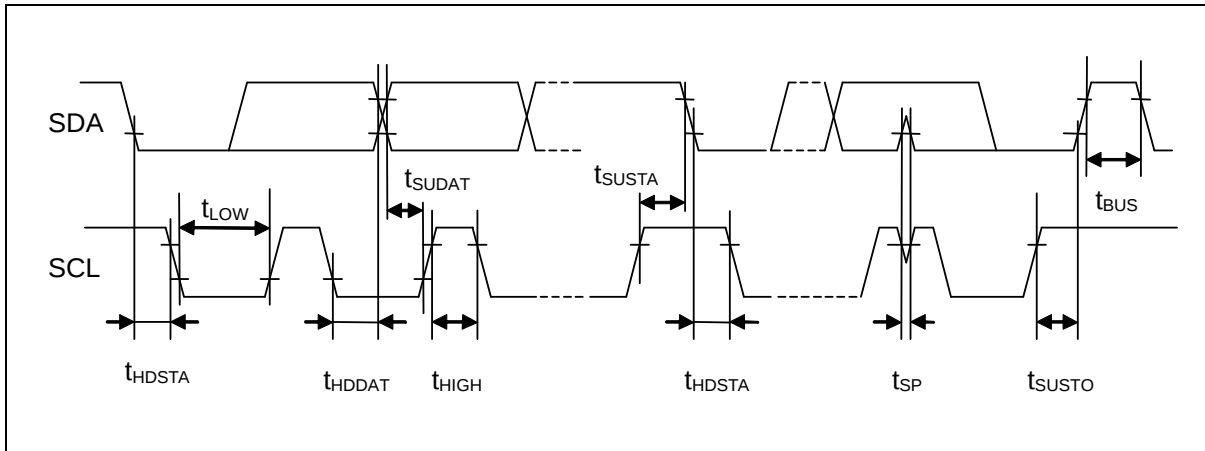
V_P indicates the power supply voltage of the pull-up resistance and I_{OL} indicates V_{OL} guaranteed current.

*2: The maximum t_{HDDAT} only has to be met if the device does not extend the "L" width (t_{LOW}) of the SCL signal.

*3: A high-speed mode I²C bus device can be used on a standard mode I²C bus system as long as the device satisfies the requirement of " $t_{SUDAT} \geq 250ns$ ".

*4: For use at over 100kHz, set the peripheral clock1 (CLKP1) to at least 6MHz.

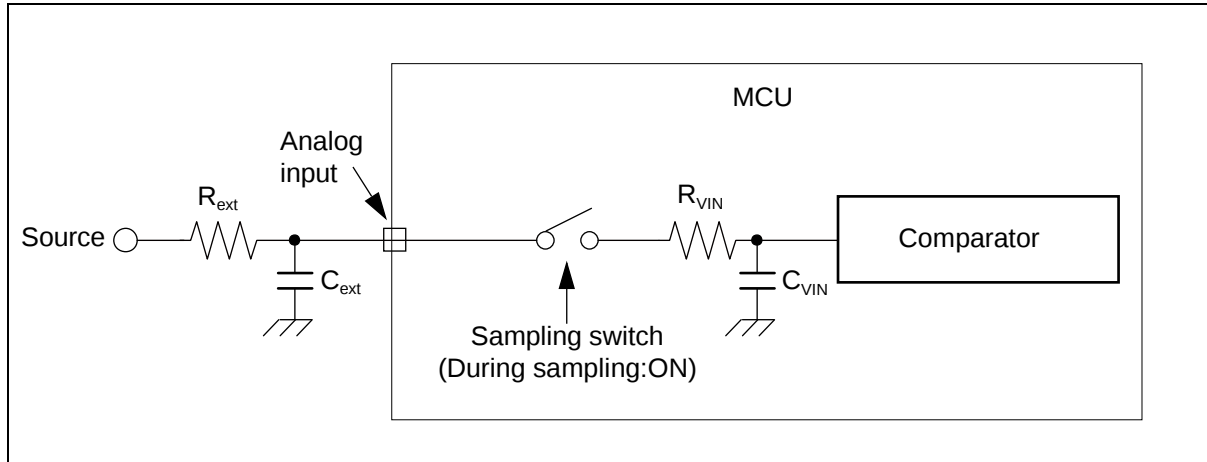
*5: t_{CLKP1} indicates the peripheral clock1 (CLKP1) cycle time.



14.5.2 Accuracy and Setting of the A/D Converter Sampling Time

If the external impedance is too high or the sampling time too short, the analog voltage charged to the internal sample and hold capacitor is insufficient, adversely affecting the A/D conversion precision.

To satisfy the A/D conversion precision, a sufficient sampling time must be selected. The required sampling time (T_{samp}) depends on the external driving impedance R_{ext} , the board capacitance of the A/D converter input pin C_{ext} and the AV_{CC} voltage level. The following replacement model can be used for the calculation:



R_{ext} : External driving impedance

C_{ext} : Capacitance of PCB at A/D converter input

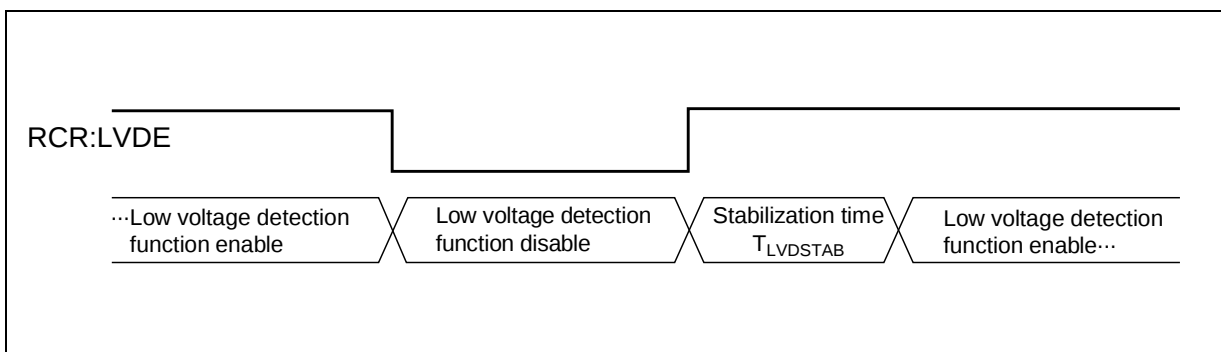
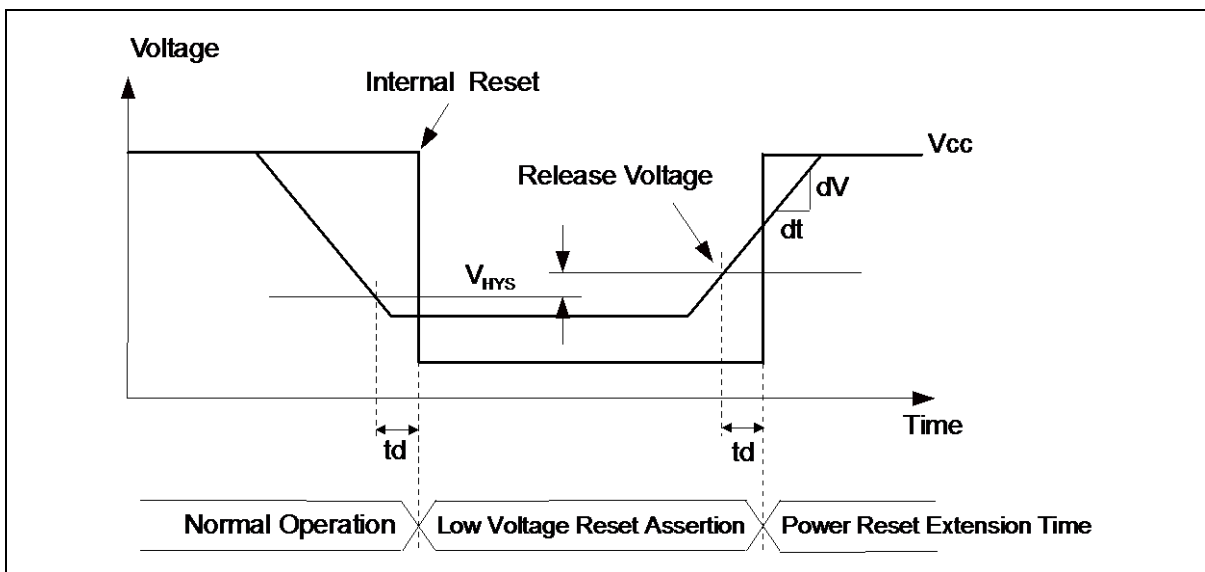
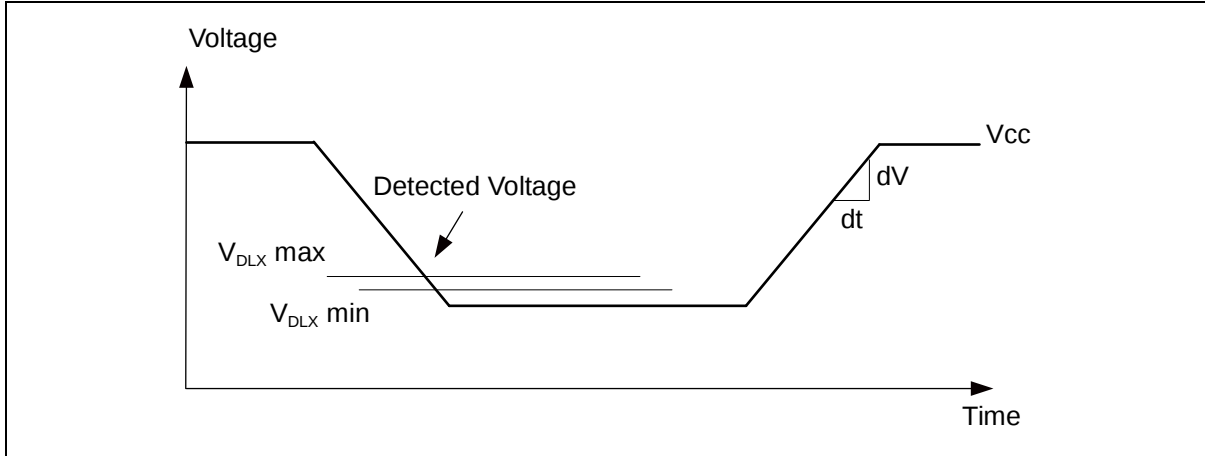
C_{VIN} : Analog input capacity (I/O, analog switch and ADC are contained)

R_{VIN} : Analog input impedance (I/O, analog switch and ADC are contained)

The following approximation formula for the replacement model above can be used:

$$T_{\text{samp}} = 7.62 \times (R_{\text{ext}} \times C_{\text{ext}} + (R_{\text{ext}} + R_{\text{VIN}}) \times C_{\text{VIN}})$$

- Do not select a sampling time below the absolute minimum permitted value.
($0.5\mu\text{s}$ for $4.5\text{V} \leq AV_{\text{CC}} \leq 5.5\text{V}$, $1.2\mu\text{s}$ for $2.7\text{V} \leq AV_{\text{CC}} < 4.5\text{V}$)
- If the sampling time cannot be sufficient, connect a capacitor of about $0.1\mu\text{F}$ to the analog input pin.
- A big external driving impedance also adversely affects the A/D conversion precision due to the pin input leakage current I_{IL} (static current before the sampling switch) or the analog input leakage current I_{AIN} (total leakage current of pin input and comparator during sampling). The effect of the pin input leakage current I_{IL} cannot be compensated by an external capacitor.
- The accuracy gets worse as $|AV_{\text{RH}} - AV_{\text{RL}}|$ becomes smaller.



14.7 Flash Memory Write/Erase Characteristics

($V_{CC} = AV_{CC} = 2.7V$ to $5.5V$, $V_{SS} = AV_{SS} = 0V$, $T_A = -40^{\circ}C$ to $+125^{\circ}C$)

Parameter		Conditions	Value			Unit	Remarks
			Min	Typ	Max		
Sector erase time	Large Sector	$T_A \leq +105^{\circ}C$	-	1.6	7.5	s	Includes write time prior to internal erase.
	Small Sector	-	-	0.4	2.1	s	
	Security Sector	-	-	0.31	1.65	s	
Word (16-bit) write time	Large Sector	$T_A \leq +105^{\circ}C$	-	25	400	μs	Not including system-level overhead time.
	Small Sector	-	-	25	400	μs	
Chip erase time		$T_A \leq +105^{\circ}C$	-	11.51	55.05	s	Includes write time prior to internal erase.

Note: While the Flash memory is written or erased, shutdown of the external power (V_{CC}) is prohibited. In the application system where the external power (V_{CC}) might be shut down while writing or erasing, be sure to turn the power off by using a low voltage detection function.

To put it concrete, change the external power in the range of change ration of power supply voltage ($-0.004V/\mu s$ to $+0.004V/\mu s$) after the external power falls below the detection voltage (V_{DLX})^{*1}.

Write/Erase cycles and data hold time

Write/Erase cycles (cycle)	Data hold time (year)
1,000	20^{*2}
10,000	10^{*2}
100,000	5^{*2}

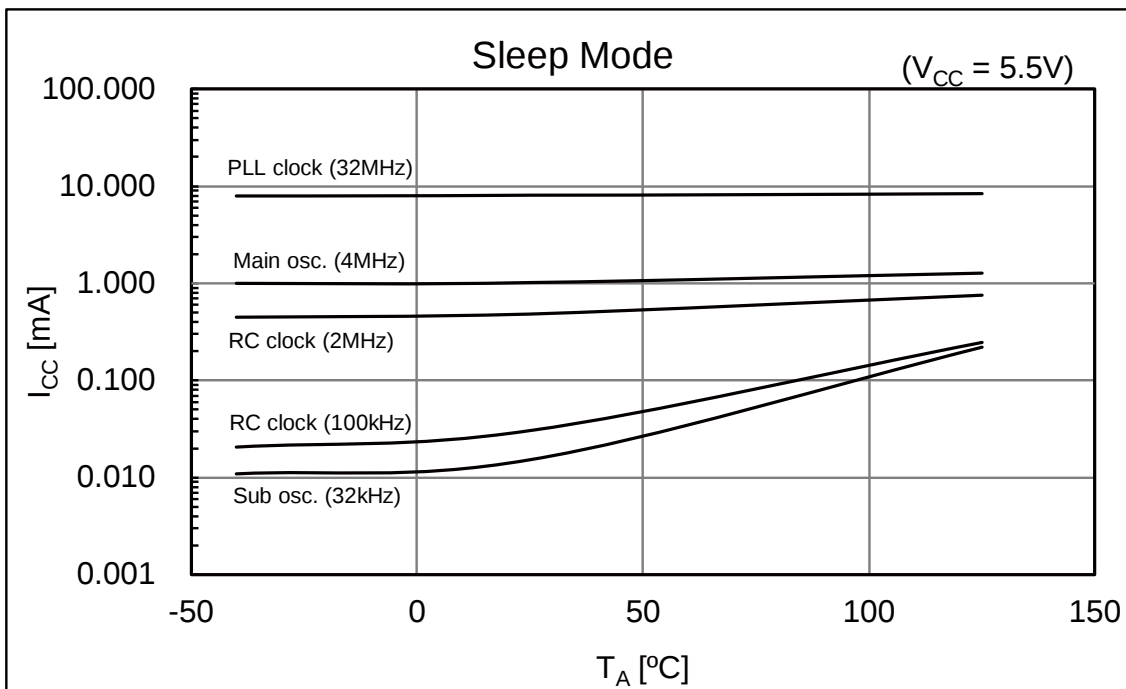
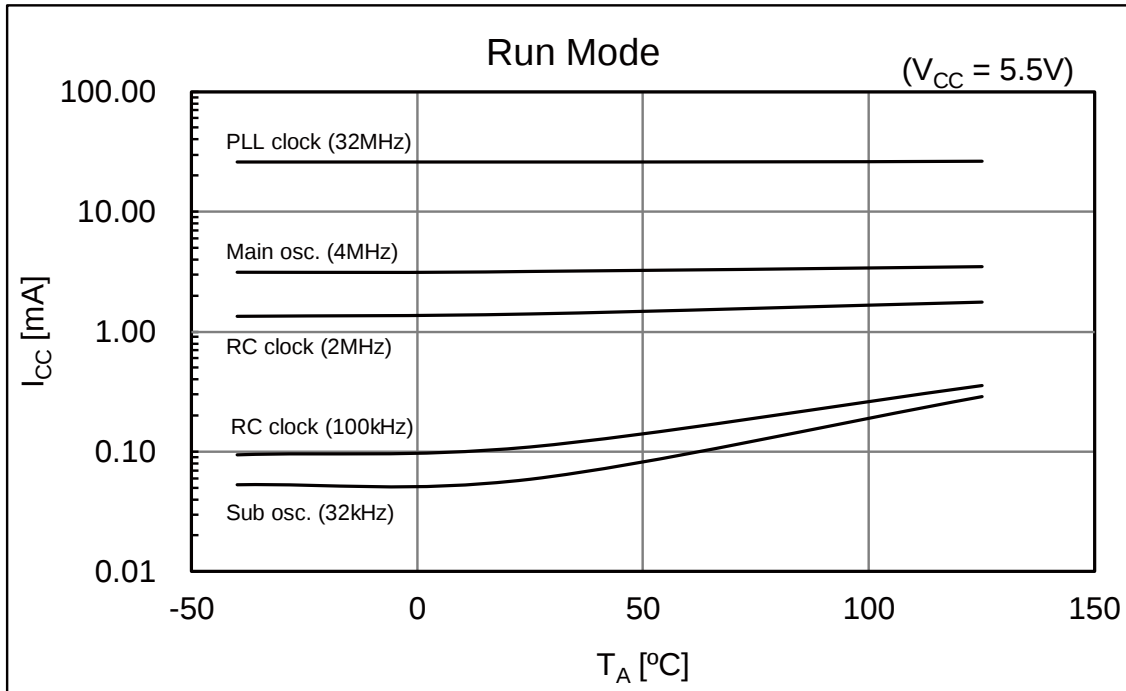
*1: See "6. Low Voltage Detection Function Characteristics".

*2: This value comes from the technology qualification (using Arrhenius equation to translate high temperature measurements into normalized value at $+85^{\circ}C$).

15. Example Characteristics

This characteristic is an actual value of the arbitrary sample. It is not the guaranteed value.

■ MB96F657



■ Used setting

Mode	Selected Source Clock	Clock/Regulator and FLASH Settings
Run mode	PLL	CLKS1 = CLKS2 = CLKB = CLKP1 = CLKP2 = 32MHz
	Main osc.	CLKS1 = CLKS2 = CLKB = CLKP1 = CLKP2 = 4MHz
	RC clock fast	CLKS1 = CLKS2 = CLKB = CLKP1 = CLKP2 = 2MHz
	RC clock slow	CLKS1 = CLKS2 = CLKB = CLKP1 = CLKP2 = 100kHz
	Sub osc.	CLKS1 = CLKS2 = CLKB = CLKP1 = CLKP2 = 32kHz
Sleep mode	PLL	CLKS1 = CLKS2 = CLKP1 = CLKP2 = 32MHz Regulator in High Power Mode, (CLKB is stopped in this mode)
	Main osc.	CLKS1 = CLKS2 = CLKP1 = CLKP2 = 4MHz Regulator in High Power Mode, (CLKB is stopped in this mode)
	RC clock fast	CLKS1 = CLKS2 = CLKP1 = CLKP2 = 2MHz Regulator in High Power Mode, (CLKB is stopped in this mode)
	RC clock slow	CLKS1 = CLKS2 = CLKP1 = CLKP2 = 100kHz Regulator in Low Power Mode, (CLKB is stopped in this mode)
	Sub osc.	CLKS1 = CLKS2 = CLKP1 = CLKP2 = 32kHz Regulator in Low Power Mode, (CLKB is stopped in this mode)
Timer mode	PLL	CLKMC = 4MHz, CLKPLL = 32MHz (System clocks are stopped in this mode) Regulator in High Power Mode, FLASH in Power-down / reset mode
	Main osc.	CLKMC = 4MHz (System clocks are stopped in this mode) Regulator in High Power Mode, FLASH in Power-down / reset mode
	RC clock fast	CLKMC = 2MHz (System clocks are stopped in this mode) Regulator in High Power Mode, FLASH in Power-down / reset mode
	RC clock slow	CLKMC = 100kHz (System clocks are stopped in this mode) Regulator in Low Power Mode, FLASH in Power-down / reset mode
	Sub osc.	CLKMC = 32 kHz (System clocks are stopped in this mode) Regulator in Low Power Mode, FLASH in Power-down / reset mode
Stop mode	stopped	(All clocks are stopped in this mode) Regulator in Low Power Mode, FLASH in Power-down / reset mode

18. Major Changes

Spancion Publication Number: MB96650_DS704-00003

Page	Section	Change Results
Revision 1.0		
-	-	Initial release
Revision 2.0		
39	Electrical Characteristics DC Characteristics Current Rating	Changed the Value of "Power supply current in Timer modes" I_{CCTPLL} Typ: 2485 μ A $\rightarrow$ 1800 μ A ($T_A = +25^\circ\text{C}$) Max: 2715 μ A $\rightarrow$ 2250 μ A ($T_A = +25^\circ\text{C}$) Max: 4095 μ A $\rightarrow$ 3220 μ A ($T_A = +105^\circ\text{C}$) Max: 5065 μ A $\rightarrow$ 4205 μ A ($T_A = +125^\circ\text{C}$)
Revision 2.1		
-	-	Company name and layout design change

NOTE: Please see "Document History" about later revised information.

Page	Section	Change Results
Revision *B		
5, 7, 62, 63	1. Product Lineup 3. Pin Assignment 16. Ordering Information 17. Package Dimension	Package description modified to JEDEC description. FPT-120P-M21 $\rightarrow$ LQM120

Document History

Document Title: MB96650 Series, F2MC-16FX 16-bit Microcontroller

Document Number: 002-04707

Revision	ECN	Orig. of Change	Submission Date	Description of Change
**	—	KSUN	01/31/2014	Migrated to Cypress and assigned document number 002-04707. No change to document contents or format.
*A	5164895	KSUN	03/14/2016	Updated to Cypress template
*B	6005555	KSUN	01/09/2018	Updated the Cypress logo, Sales information and legal. Refer to 18. Major Changes.